



Atty. Dkt. No.	M#	Client Ref.
	0306010	P-1533.010-US
Applicant: DEN BOEF et al.		
Appln. No.: 10/665,720		
Filing Date: September 22, 2003		
Examiner: Le		Group Art Unit: 2878

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Date: January 30, 2004

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U.S. PATENT DOCUMENTS

Examiner's Initials*		Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
QL	AR	4,037,969	07/1977	FELDMAN et al.			
	BR	4,236,805	04/1982	FELDMAN et al.			
	CR	4,251,160	02/1981	BOUWHUIS et al.			
	DR	4,355,892	10/1982	MAYER et al.			
	ER	4,398,824	08/1983	FELDMAN et al.			
	FR	4,514,858	04/1985	NOVAK			
	GR	4,540,277	09/1985	MAYER et al.			
	HR	4,614,432	09/1986	KUNIYOSHI et al.			
	IR	4,690,529	09/1987	SUGIYAMA et al.			
	JR	4,710,026	12/1987	MAGOME et al.			
	KR	4,748,333	05/1988	MIZUTANI et al.			
	LR	4,778,275	10/1988	VAN DEN BRINK et al.			
	MR	4,814,829	03/1989	KOSUGI et al.			
	NR	4,828,392	05/1989	NOMURA et al.			
	OR	4,857,744	08/1989	KATAOKA et al.			
	PR	4,861,162	08/1989	INA			
	QR	4,870,452	09/1989	TANIMOTO et al.			
	RR	4,952,970	08/1990	SUZUKI et al.			
	SR	5,100,237	03/1992	WITTEKOEK et al.			
	TR	5,114,236	05/1992	MATSUGU et al.			
QL	UR	5,118,953	06/1992	OTA et al.			

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		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract	Translation Readily Available
						Enclosed	No
QL	VR	11-329914	11/1999	Japan	SAKO TAKASHI	X	X
	WR						
	XR						
	YR						

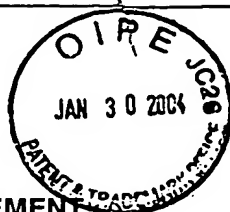
OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

QL	ZR	Markle, D. A., "Submicron 1:1 Optical Lithography", Semi-conductor International, pp. 173-142, May 1986.	X		
	AAR				
	BBR				
	CCR				

Examiner /Que Tan Le/

Date Considered: 06/23/2006

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U.S. PATENT DOCUMENTS

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QL	AR	5,144,363	09/1992	WITTEKOEK et al.			
	BR	5,151,754	09/1992	ISHIBASHI et al.			
	CR	5,160,849	11/1992	OTA et al.			
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	LR	5,596,204	01/1997	IRIE et al.			
	MR	5,801,390	09/1998	SHIRAISHI			
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	TR	6,242,754 B1	06/2001	SHIRAISHI et al.			
QL	UR	6,297,876 B1	10/2001	BORNEBROEK			

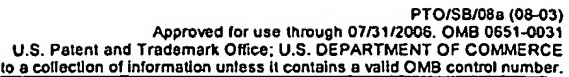
FOREIGN PATENT DOCUMENTS

ORIGINAL PAPER DOCUMENTS							Abstract		Readily Available	
		Document Number	Date MM/YYYY	Country	Inventor Name		Enclosed	No	Enclose	No
	VR									
	WR									
	XR									
	YR									

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

	ZR						
	AAR						
	BBR						
	CCR						
	DDR						

Examiner /Que Tan Le/	Date Considered: 06/23/2006
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Sheet	1	of	1	Attorney Docket Number	081468-0306010
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FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ Number ⁴ Kind Code ⁵ (if known)				
QL	1	JP 3-257303	11-15-1991			X

Examiner Signature	/Que Tan Le/	Date Considered	06/23/2006
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